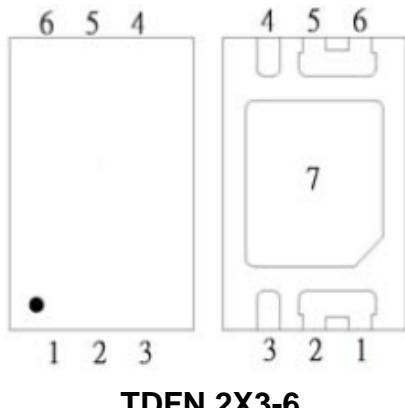


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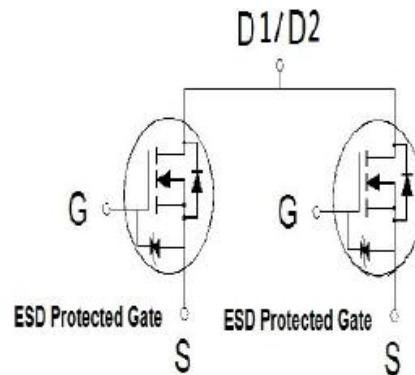
Dual N-Channel Enhancement Mode MOSFET

PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
20V	19.5mΩ @ $V_{GS} = 4.5V$	7A



1,2:S1
 3:G1
 4:G2
 5,6:S2
 7:D1/D2



TDFN 2X3-6

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ C$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS	SYMBOL	LIMITS	UNITS
Drain-Source Voltage	V_{DS}	20	V
Gate-Source Voltage	V_{GS}	± 8	V
Continuous Drain Current	I_D	7	A
$T_A = 70^\circ C$		6	
Pulsed Drain Current ¹	I_{DM}	25	
Avalanche Current	I_{AS}	13	
Avalanche Energy ³	E_{AS}	8.5	mJ
Power Dissipation	P_D	1.8	W
$T_A = 25^\circ C$		1.2	
Junction & Storage Temperature Range	T_j, T_{stg}	-55 to 150	°C

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient ²	$R_{\theta JA}$		68	°C / W

¹Pulse width limited by maximum junction temperature.

²The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper,in a still air environment with $T_A = 25^\circ C$.

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Dual N-Channel Enhancement Mode MOSFET

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$, Unless Otherwise Noted)

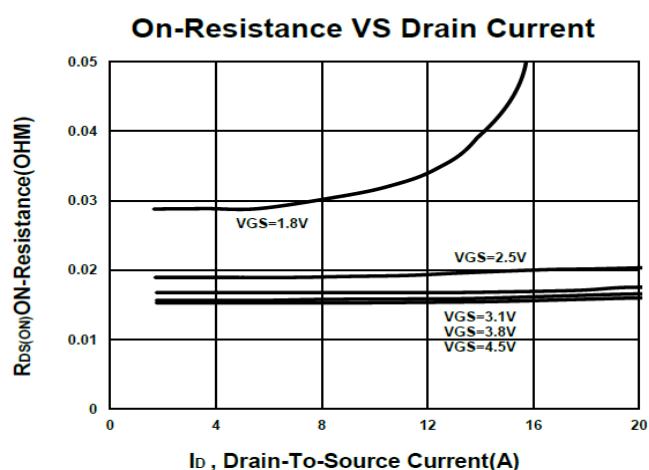
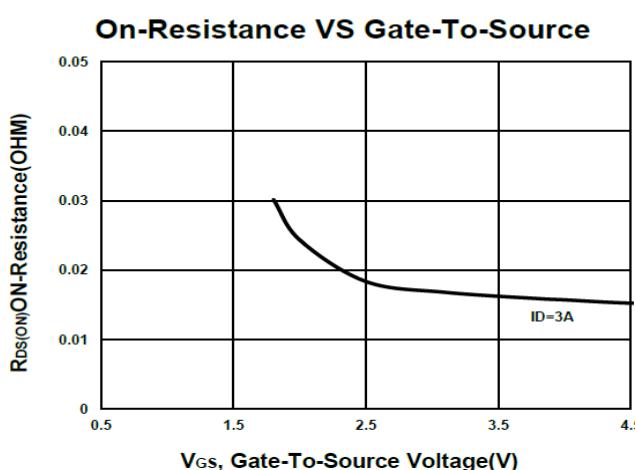
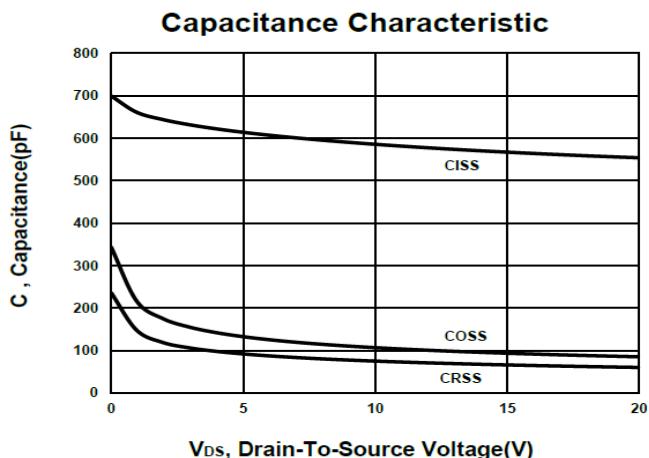
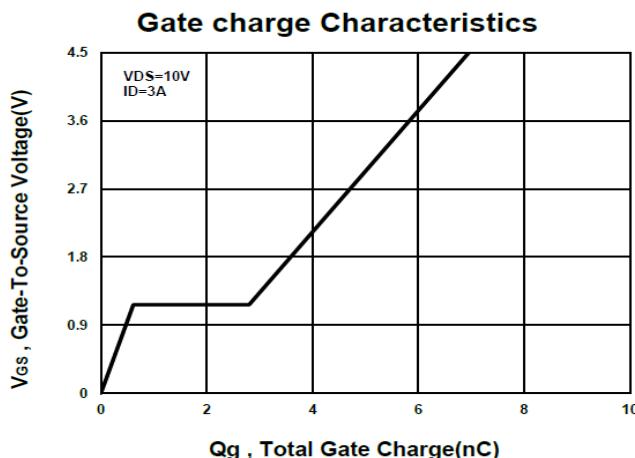
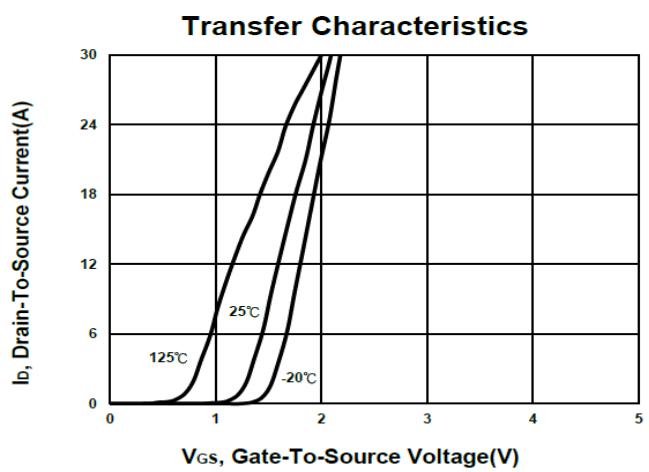
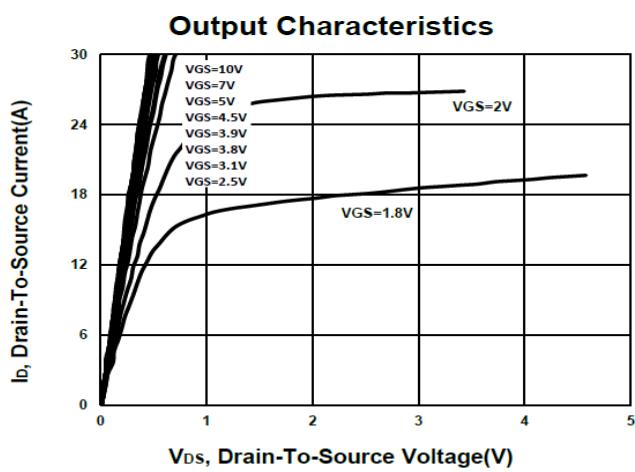
PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNITS
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$	20			V
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250\mu\text{A}$	0.35	0.8	1	
Gate-Body Leakage	I_{GSS}	$V_{\text{DS}} = 0\text{V}, V_{\text{GS}} = \pm 8\text{V}$			± 30	μA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}} = 16\text{V}, V_{\text{GS}} = 0\text{V}$			1	μA
		$V_{\text{DS}} = 10\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 125^\circ\text{C}$			10	
Drain-Source On-State Resistance ¹	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}} = 4.5\text{V}, I_D = 3\text{A}$		14.8	19.5	$\text{m}\Omega$
		$V_{\text{GS}} = 3.8\text{V}, I_D = 3\text{A}$		15.3	23	
		$V_{\text{GS}} = 3.1\text{V}, I_D = 3\text{A}$		16.5	24.5	
		$V_{\text{GS}} = 2.5\text{V}, I_D = 3\text{A}$		18.6	28	
		$V_{\text{GS}} = 1.8\text{V}, I_D = 3\text{A}$		28	40	
Forward Transconductance ¹	g_{fs}	$V_{\text{DS}} = 5\text{V}, I_D = 3\text{A}$		30		S
DYNAMIC						
Input Capacitance	C_{iss}	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 10\text{V}, f = 1\text{MHz}$		593		pF
Output Capacitance	C_{oss}			111		
Reverse Transfer Capacitance	C_{rss}			85		
Total Gate Charge ²	$Q_g(V_{\text{GS}}=4.5\text{V})$	$V_{\text{DS}} = 10\text{V}, I_D = 3\text{A}$		8.2		nC
	$Q_g(V_{\text{GS}}=3.8\text{V})$			7		
Gate-Source Charge ²	Q_{gs}			0.7		
Gate-Drain Charge ²	Q_{gd}			3		
Turn-On Delay Time ²	$t_{\text{d(on)}}$	$V_{\text{DD}} = 10\text{V}$ $I_D \geq 3\text{A}, V_{\text{GS}} = 4.5\text{V}, R_{\text{GS}} = 6\Omega$		15		nS
Rise Time ²	t_r			25		
Turn-Off Delay Time ²	$t_{\text{d(off)}}$			35		
Fall Time ²	t_f			13		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_J = 25^\circ\text{C}$)						
Continuous Current	I_S				1.5	A
Forward Voltage ¹	V_{SD}	$I_F = 3\text{A}, V_{\text{GS}} = 0\text{V}$			1.2	V
Reverse Recovery Time	t_{rr}	$I_F = 3\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$		10		nS
Reverse Recovery Charge	Q_{rr}			2.6		nC

¹Pulse test : Pulse Width $\leq 300\ \mu\text{sec}$, Duty Cycle $\leq 2\%$.

²Independent of operating temperature.

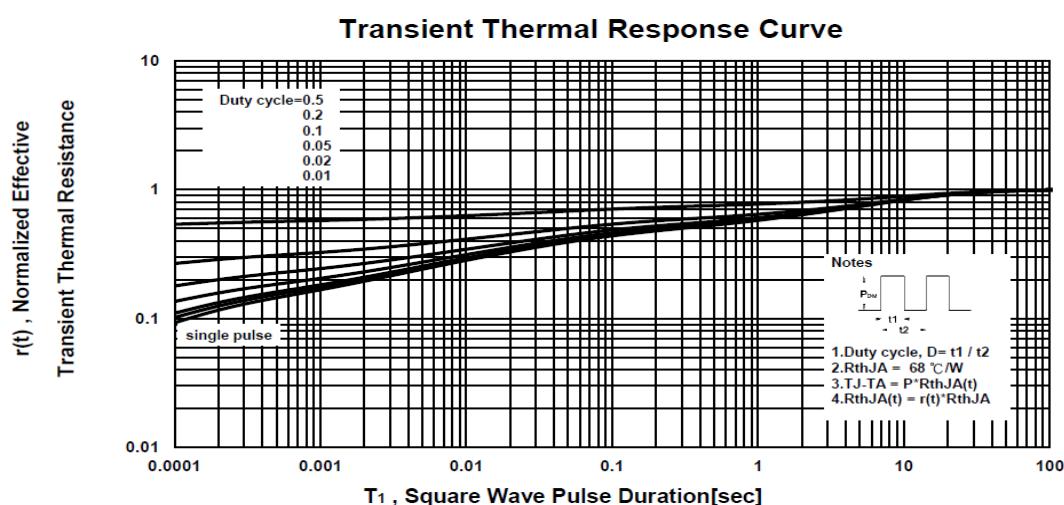
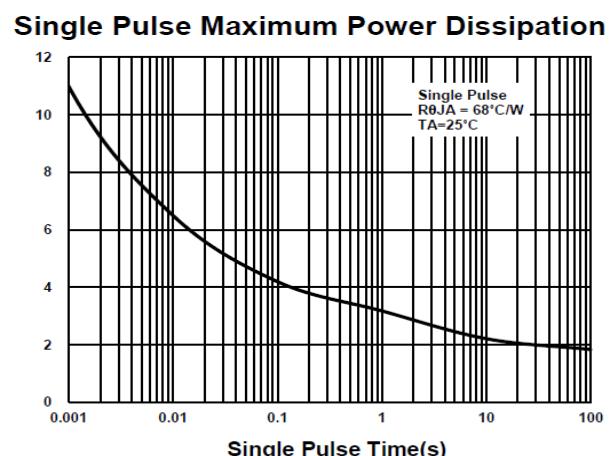
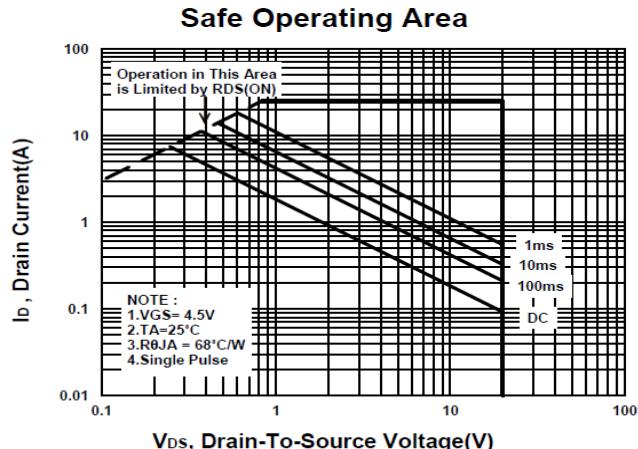
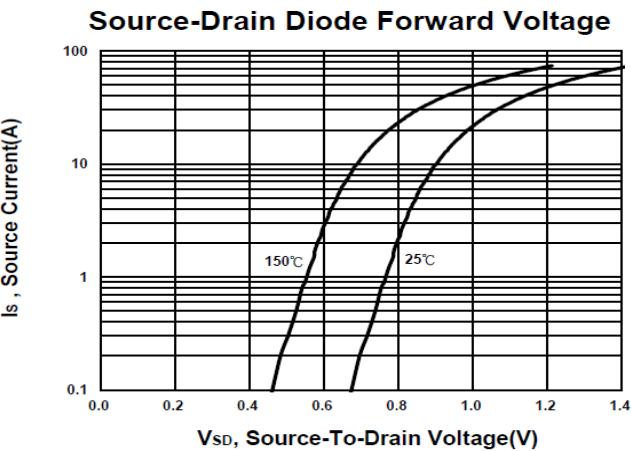
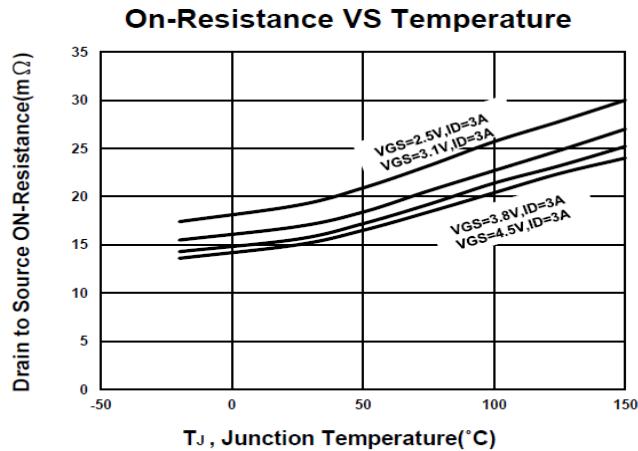
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Dual N-Channel Enhancement Mode MOSFET



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Dual N-Channel Enhancement Mode MOSFET



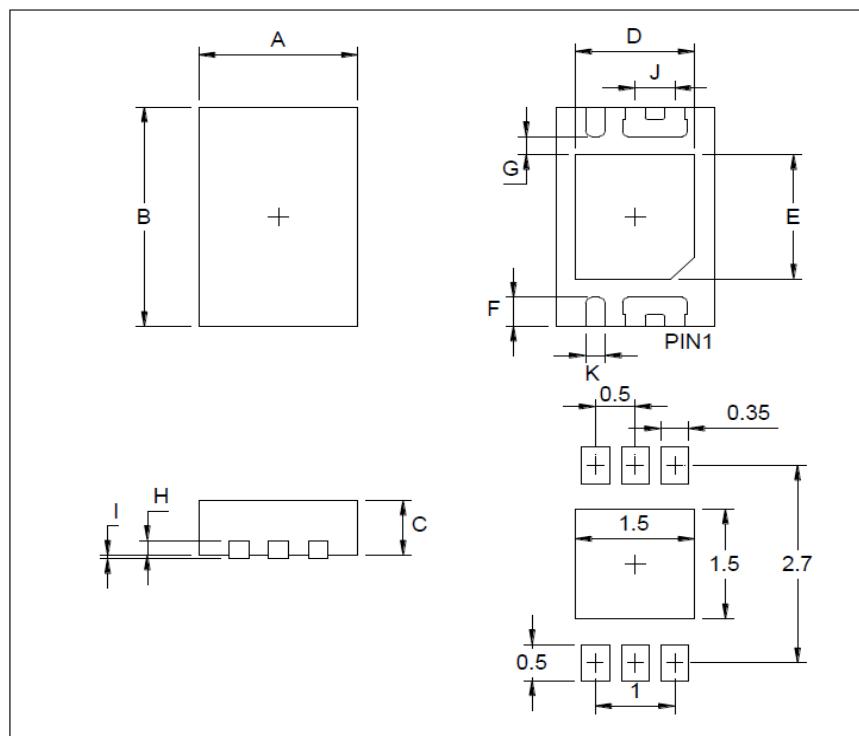
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Dual N-Channel Enhancement Mode MOSFET

Package Dimension

TDFN 2x3-6 MECHANICAL DATA

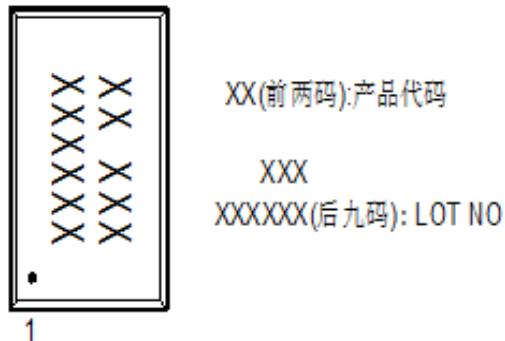
Dimension	mm			Dimension	mm		
	Min.	Typ.	Max.		Min.	Typ.	Max.
A	1.95	2.00	2.05	H	0.195	0.203	0.211
B	2.95	3.00	3.05	I	0		0.05
C	0.70	0.75	0.8	J		0.50	
D	1.45	1.50	1.55	K	0.20	0.25	0.30
E	1.65	1.70	1.75				
F	0.35	0.40	0.45				
G	0.25						



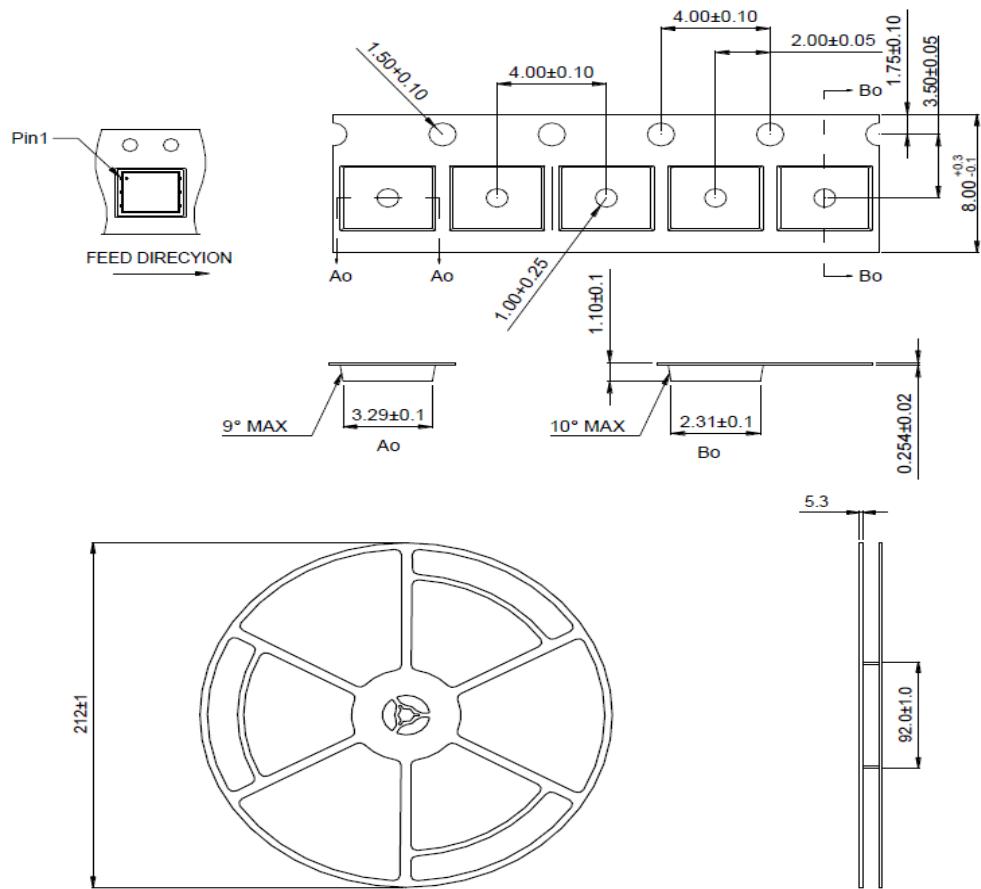
PB6C4JU

Dual N-Channel Enhancement Mode MOSFET

A. Marking Information (此产品代码为：D7)



B. Tape&Reel Information: 3000pcs/Reel



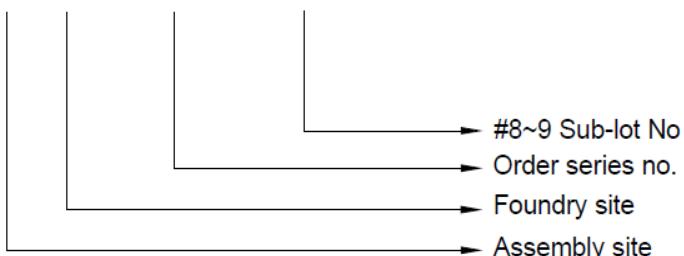
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Dual N-Channel Enhancement Mode MOSFET

C. Lot.No. & Date Code rule

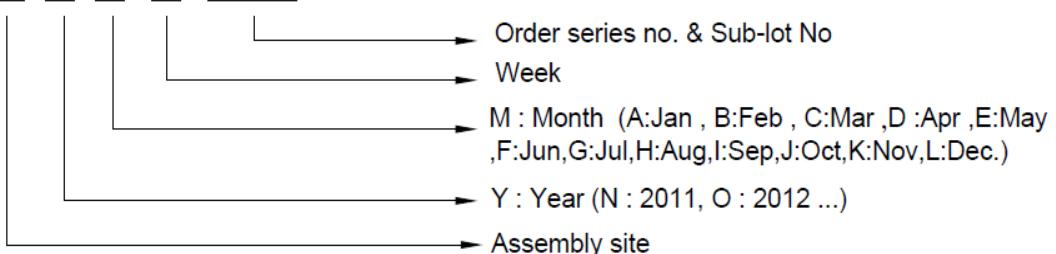
1.LOT.NO.

M N 15M21 03



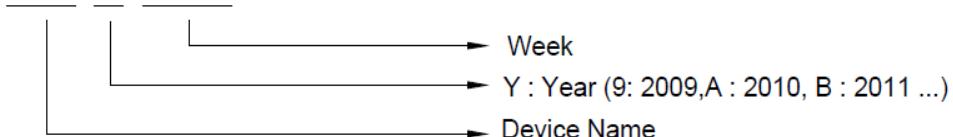
2.Date Code

D Y M X XXX



3.Date Code (for Small package)

XX Y WW



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Dual N-Channel Enhancement Mode MOSFET

D.Label rule

标签内容(Label content)



1	Label Size	30 * 90 mm
2	Font style	Times New Roman or Arial (或可区分英文“0”和数字“0”，“G”和“Q”的字型即可)
3	Great Power	Height: 4 mm
4	Package	Height: 2 mm
5	Date	Height: 2 mm Shipping date: YYYY/MM/DD, ex. 2008/09/12
6	Device	Height: 3 mm (Max: 16 Digit)
7	Lot	Height: 3 mm (Max: 9 Digit) Sub lot
8	D/C	Height: 3 mm (Max: 7 Digit)
9	QTY	Height: 3 mm (Max: 6 Digit) Thousand mark is no needed
10	Pb Free label	 Diameter: 1 cm bottom color: Green Font color: Black Font style: Arial
11	Halogen Free label	 Diameter: 1 cm bottom color: Green Font color: Black Font style: Arial
12	Scan info	Device / Lot / D/C / QTY , Insert “ / ” between every parts. for example: P3055LDG/G12345601/GGG2301/2000 DPI (Dots per inch): Over 300 dpi Code : Code 128 Height: 6 mm at least